

Notice of References Cited	Application/Control No. 10/596,717		Applicant(s)/Patent Under Reexamination DENOON-STEVENS ET AL.	
	Examiner STEPHEN CLAWSON		Art Unit 4172	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0017845	01-2003	Doviak et al.	455/556
*	C	US-2002/0159402	10-2002	Binder, Yehuda	370/296
*	D	US-2003/0084112	05-2003	Curray et al.	709/208
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NON-PATENT DOCUMENTS

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	U	Desmarais, Louis. Applied Electro-Optics. Prentice Hall. 12/5/1997 pg. 244
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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